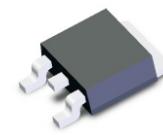


CMS16N06D-HF

**N-Channel
RoHS Device
Halogen Free**



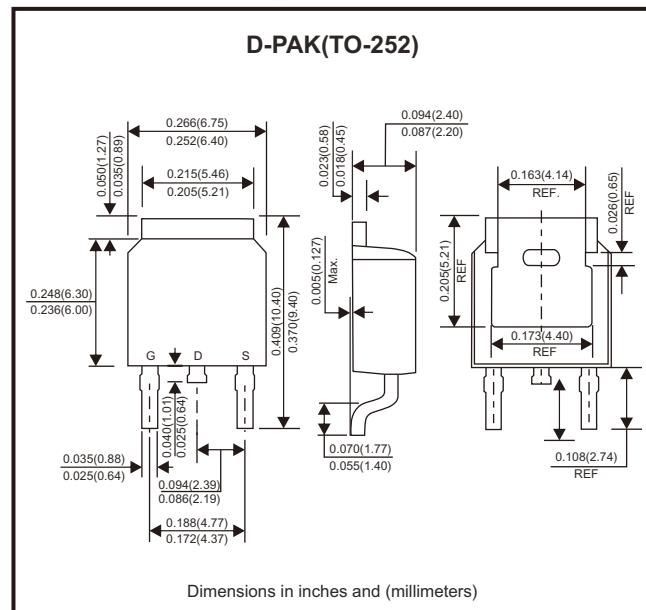
Features

- Low Reverse Transfer Capacitance
- High Switching Speed
- Improved dv/dt Capability
- 100% EAS Guaranteed
- Green Device Available

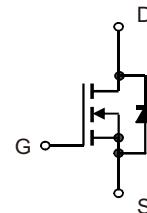
Description

The CMS16N06D is the highest performance N-CH MOSFET with super high dense cell design for extremely low $R_{DS(on)}$ and gate charge for most of the synchronous buck converter applications.

The CMS16N06D meet the RoHS and green product requirement, 100% EAS guaranteed with full function reliability approved.



Circuit diagram



- G : Gate
- S : Source
- D : Drain

Maximum Ratings (at $T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	$I_D @ T_C=25^\circ\text{C}$	16	A
	$I_D @ T_C=100^\circ\text{C}$	10	A
Pulsed Drain Current ^{1,2}	$I_{DM} @ T_C=25^\circ\text{C}$	64	A
Continuous Drain Current	$I_D @ T_A=25^\circ\text{C}$	4.4	A
	$I_D @ T_A=70^\circ\text{C}$	3.5	A
Total Power Dissipation ⁴	$P_D @ T_C=25^\circ\text{C}$	27	W
	$P_D @ T_A=25^\circ\text{C}$	2	W
Single Pulse Avalanche Energy, $L=0.1\text{mH}^3$	E_{AS}	11	mJ
Single Pulse Avalanche Current, $L=0.1\text{mH}^3$	I_{AS}	15	A
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 ~ +150	°C

Thermal Data

Parameter	Symbol	Conditions	Max. Value	Unit
Thermal Resistance Junction-ambient ¹	$R_{\theta JA}$	Steady State	62.5	°C/W
Thermal Resistance Junction-case ¹	$R_{\theta JC}$	Steady State	4.6	°C/W

Company reserves the right to improve product design , functions and reliability without notice.

REV:A

Electrical Characteristics (at $T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	60	-	-	V	$\text{V}_{\text{GS}}=0$, $\text{I}_D=250\mu\text{A}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	1.0	1.8	2.5	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}$, $\text{I}_D=250\mu\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 20\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$\text{V}_{\text{DS}}=60\text{V}$, $\text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance ²	$\text{R}_{\text{DS}(\text{ON})}$	-	37	50	$\text{m}\Omega$	$\text{V}_{\text{GS}}=10\text{V}$, $\text{I}_D=8\text{A}$
		-	42	60		$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=4\text{A}$
Total Gate Charge ²	Q_g	-	14	-	nC	$\text{I}_D=4\text{A}$ $\text{V}_{\text{DS}}=30\text{V}$ $\text{V}_{\text{GS}}=10\text{V}$
Gate-Source Charge	Q_{gs}	-	2.9	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	2.3	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	3.9	-	ns	$\text{V}_{\text{DS}}=30\text{V}$ $\text{I}_D=1\text{A}$ $\text{V}_{\text{GS}}=10\text{V}$ $\text{R}_G=3.3\Omega$
Rise Time	T_r	-	13	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	23	-		
Fall Time	T_f	-	6.7	-		
Input Capacitance	C_{iss}	-	815	-	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=15\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	379	-		
Reverse Transfer Capacitance	C_{rss}	-	110	-		

Guaranteed Avalanche Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Single Pulse Avalanche Energy ⁵	EAS	3.2	-	-	μJ	$\text{V}_{\text{DD}}=25\text{V}$, $L=0.1\text{mH}$, $\text{I}_{\text{AS}}=8\text{A}$

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Diode Forward Voltage ²	V_{SD}	-	0.73	1.0	V	$\text{I}_S=1\text{A}$, $\text{V}_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$
Continuous Source Current ^{1,6}	I_S	-	-	16	A	---

Notes: 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2. The data tested by pulsed, pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.
3. The EAS data shows Max. rating. The test condition is $\text{V}_{\text{DD}}=25\text{V}$, $\text{V}_{\text{GS}}=10\text{V}$, $L=0.1\text{mH}$, $\text{I}_{\text{AS}}=15\text{A}$.
4. The power dissipation is limited by 150°C junction temperature.
5. The Min. value is 100% EAS tested guarantee.
6. The data is theoretically the same as ID and IDM , in real applications, should be limited by total power dissipation.

RATING AND CHARACTERISTIC CURVES

Typical Characteristics

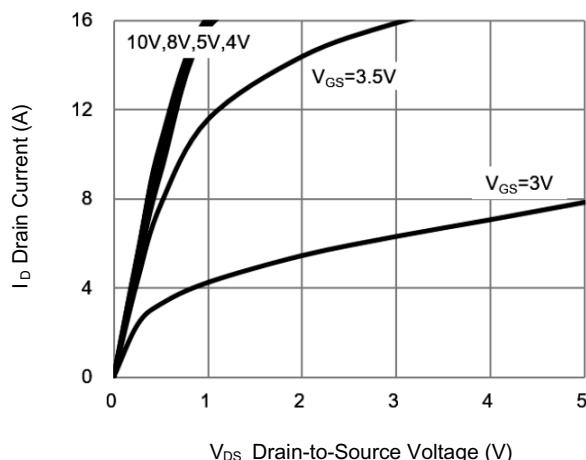


Fig.1 Typical Output Characteristics

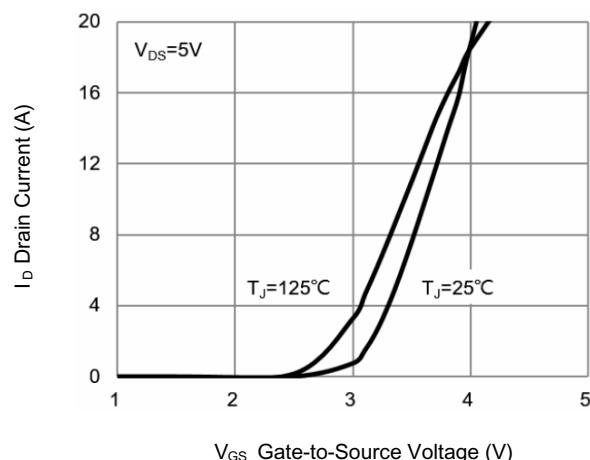


Fig.2 Transfer Characteristics

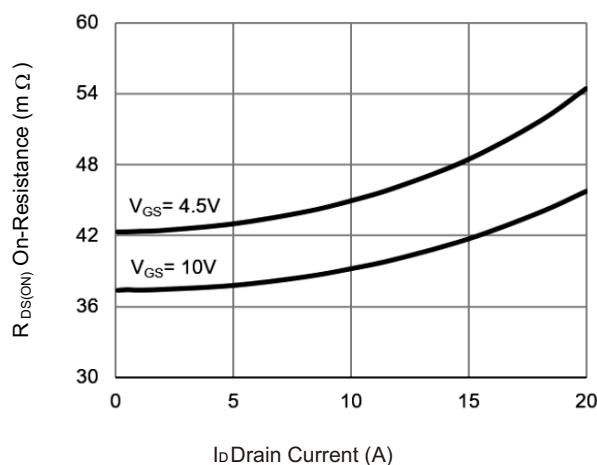


Fig.3 On-Resistance vs. Drain Current

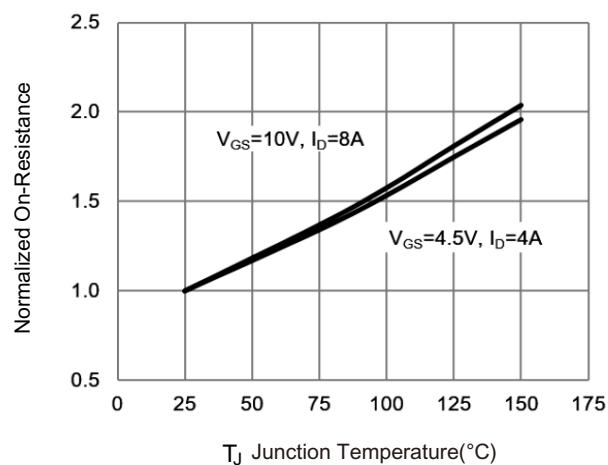


Fig.4 Normalized $R_{DS(on)}$ vs. T_J

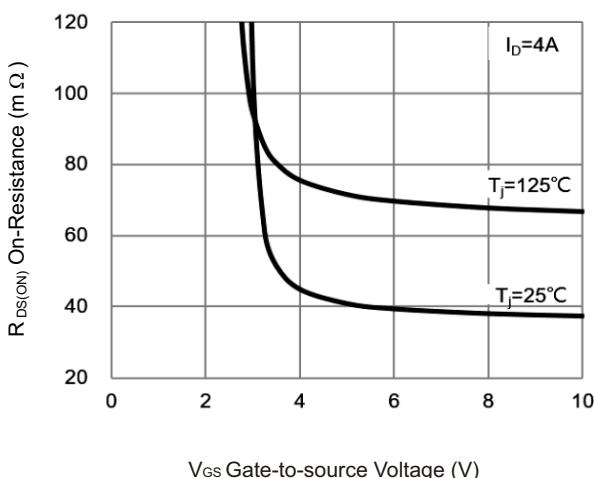


Fig.5 On-Resistance vs. G-S Voltage

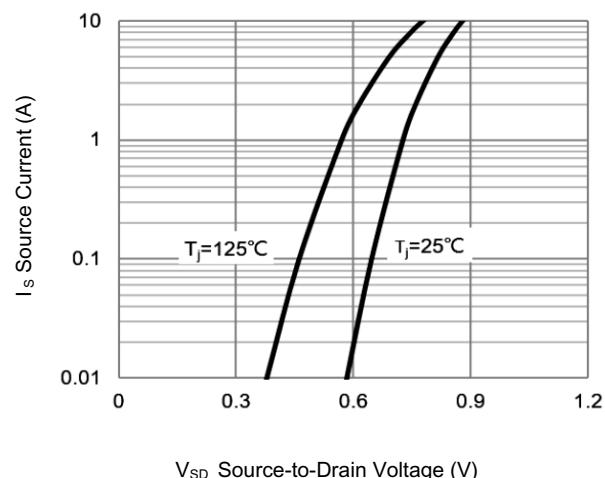


Fig.6 Forward Characteristics of Reverse

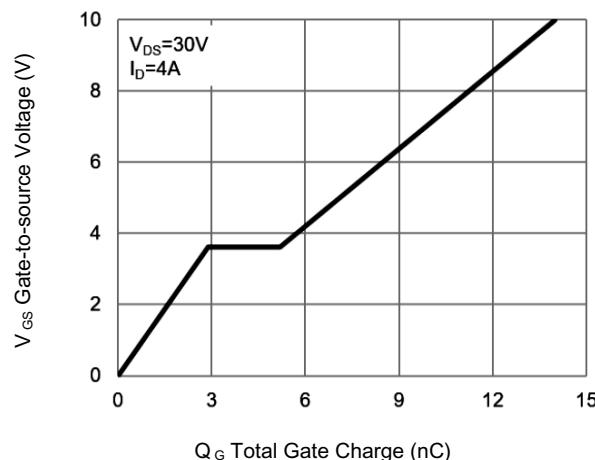


Fig.7 Gate Charge Characteristics

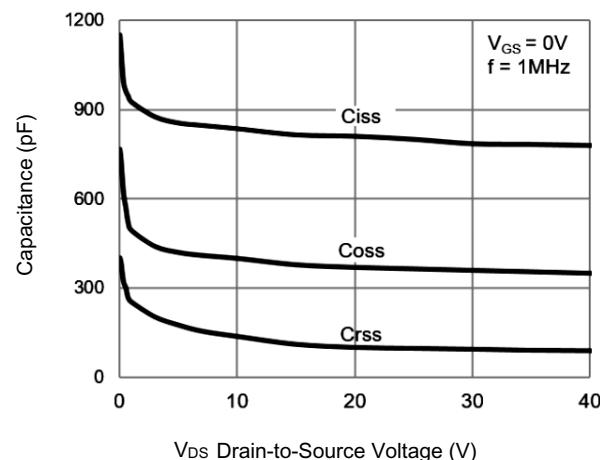


Fig.8 Capacitance Characteristics

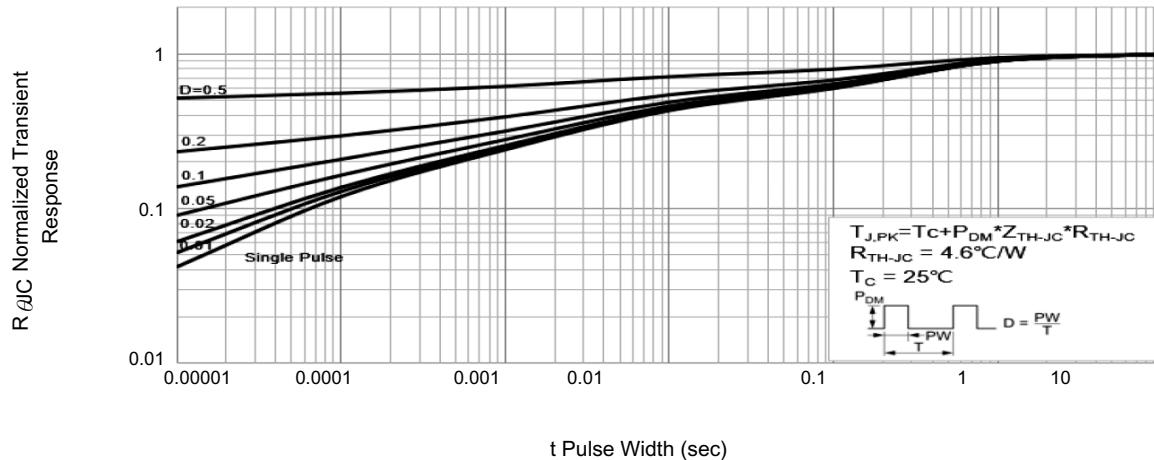


Fig.9 Normalized Maximum Transient Thermal Impedance

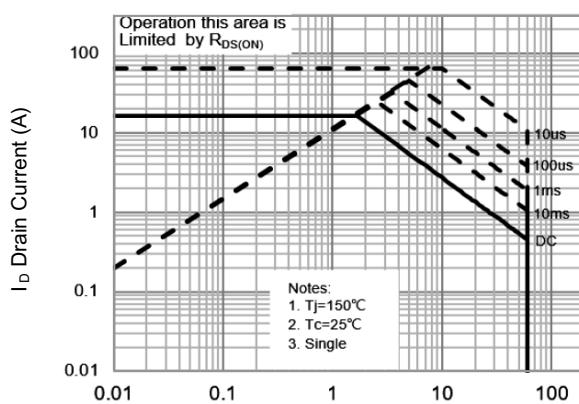


Fig.10 Safe Operating Area

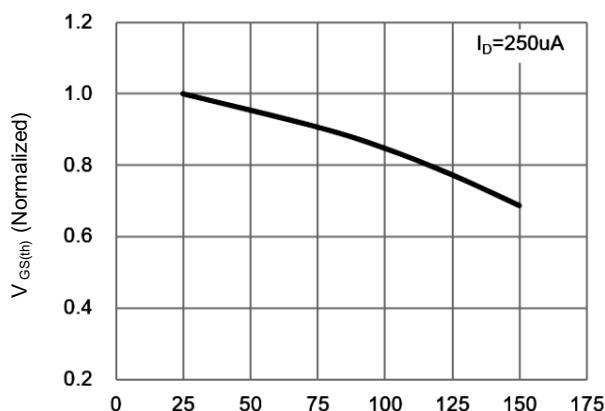
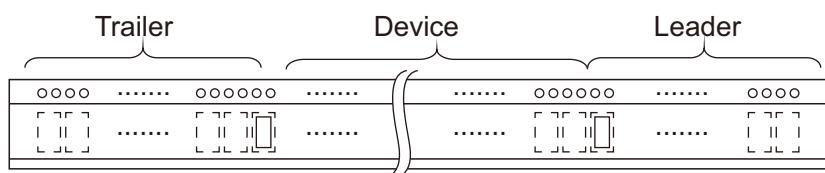
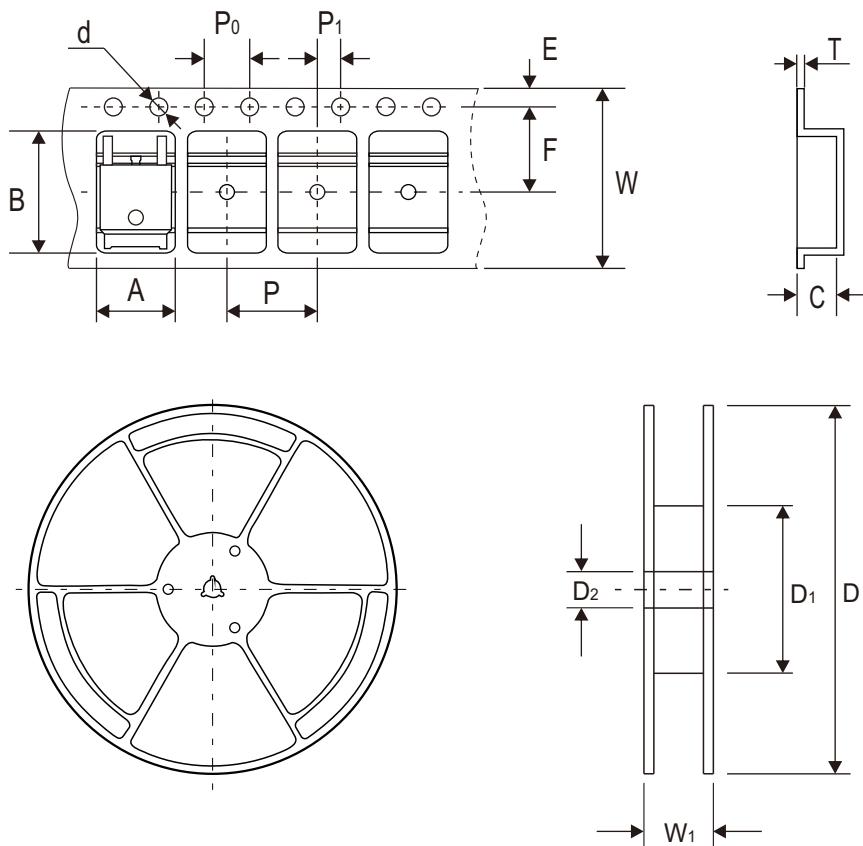


Fig.11 Normalized $V_{GS(th)}$ vs. Temperature

Reel Taping Specification



TO-252 (D-PAK)	SYMBOL	A	B	C	d	D	D ₁	D ₂
	(mm)	6.90 ± 0.10	10.50 ± 0.10	2.70 ± 0.10	1.55 ± 0.05	330.00 ± 2.00	100.00 ± 2.00	13.00 ± 1.00
	(inch)	0.272 ± 0.004	0.413 ± 0.004	0.106 ± 0.004	0.061 ± 0.002	12.992 ± 0.079	3.937 ± 0.079	0.512 ± 0.039

TO-252 (D-PAK)	SYMBOL	E	F	P	P ₀	P ₁	T	W	W ₁
	(mm)	1.75 ± 0.10	7.50 ± 0.10	8.00 ± 0.10	4.00 ± 0.10	2.00 ± 0.10	0.30 ± 0.05	16.00 ± 0.10	21.00 ± 1.00
	(inch)	0.069 ± 0.004	0.295 ± 0.004	0.315 ± 0.004	0.157 ± 0.004	0.079 ± 0.004	0.012 ± 0.002	0.630 ± 0.004	0.827 ± 0.039

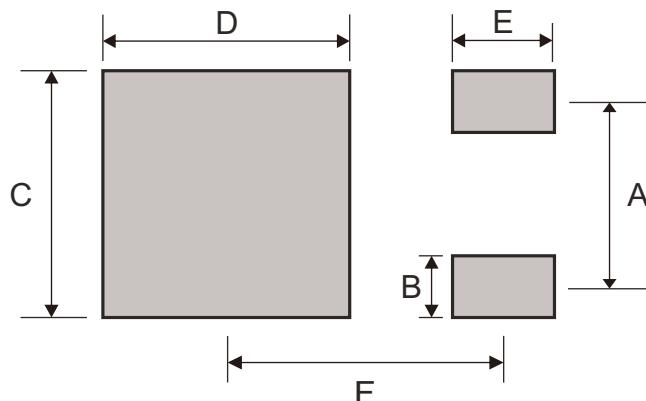
Marking Code

Part Number	Marking Code
CMS16N06D-HF	16N06A



Suggested PAD Layout

SIZE	TO-252 / DPAK	
	(mm)	(inch)
A	4.60	0.181
B	1.40	0.055
C	6.00	0.236
D	6.50	0.256
E	3.00	0.118
F	6.25	0.246



Standard Packaging

Case Type	REEL PACK	
	REEL (pcs)	REEL SIZE (inch)
TO-252/D-PAK	2,500	13